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Kind regards,

Team Nexperia

PHN210T

Dual N-channel TrenchMOS intermediate level FET Rev. 02 — 15 December 2010 Produ

Product data sheet

Product profile 1.

1.1 General description

Dual intermediate level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Suitable for high frequency applications due to fast switching characteristics
- Suitable for logic level gate drive sources
- Suitable for low gate drive sources

1.3 Applications

- DC-to-DC converters
- Logic level translators

Motor and relay drivers

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	$T_j \ge 25$ °C; $T_j \le 150$ °C; Repetitive peak drain-source voltage		-	-	30	V
I _D	drain current	T _{sp} = 25 °C; Single device	<u>[1]</u>	-	-	3.4	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C	[2]	-	-	2	W
Static chara	acteristics						
R _{DSon}	drain-source on-state	$V_{GS} = 4.5 \text{ V}; I_D = 1 \text{ A};$ $T_j = 25 \text{ °C}$		-	120	200	mΩ
	resistance	$V_{GS} = 10 \text{ V}; I_D = 2.2 \text{ A};$ $T_j = 25 \text{ °C}$		-	80	100	mΩ
Dynamic characteristics							
Q_{GD}	gate-drain charge	$V_{GS} = 10 \text{ V}; I_D = 2.3 \text{ A};$ $V_{DS} = 15 \text{ V}; T_j = 25 ^{\circ}\text{C}$		-	0.7	-	nC

^[1] Surface mounted on FR4 board, t ≤ 10 sec.



^[2] Surface mounted on FR4, t ≤ 10 sec.

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2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source1		B. B. B. B. B.
2	G1	gate1	8 <u> </u>	D1 D1 D2 D2
3	S2	source2		
4	G2	gate2		
5	D	drain2	1	
6	D	drain2	SOT96-1 (SO8)	S1 G1 S2 G2
7	D	drain1		mbk725
8	D	drain1		

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PHN210T	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1

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4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DS}	drain-source voltage	Continuous		-	30	V
		$T_j \ge 25$ °C; $T_j \le 150$ °C; Repetitive peak drain-source voltage		-	30	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	30	V
V_{GS}	gate-source voltage			-20	20	V
I_D	drain current	T _{sp} = 70 °C; Dual device	[1]	-	1.9	Α
		T _{sp} = 70 °C; Single device	<u>[1]</u>	-	2.8	Α
		T _{sp} = 25 °C; Dual device	<u>[1]</u>	-	2.4	Α
		T _{sp} = 25 °C; Single device	<u>[1]</u>	-	3.4	Α
I _{DM}	peak drain current	T _{sp} = 25 °C; pulsed		-	14	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C	[2]	-	2	W
T_{stg}	storage temperature			-65	150	°C
Tj	junction temperature			-65	150	°C
Source-drai	in diode					
I _S	source current	$T_{sp} = 25 ^{\circ}C$		-	2.2	Α
I_{SM}	peak source current	T_{sp} = 25 °C; pulsed		-	14	Α
Avalanche i	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 3.4 A; V_{DD} ≤ 15 V; unclamped; R_{GS} = 50 Ω ; t_p = 0.2 ms		-	13	mJ
I _{AS}	non-repetitive avalanche current	$V_{sup} \le$ 15 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; R_{GS} = 50 Ω ; unclamped		-	3.4	Α

^[1] Surface mounted on FR4 board, $t \le 10$ sec.

^[2] Surface mounted on FR4, $t \le 10$ sec.

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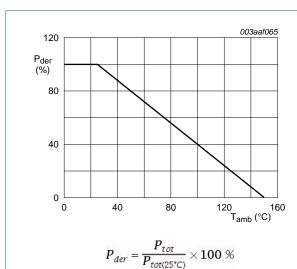


Fig 1. Normalized total power dissipation as a function of ambient temperature

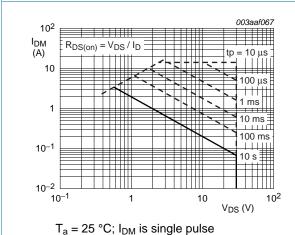
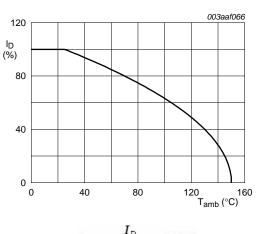
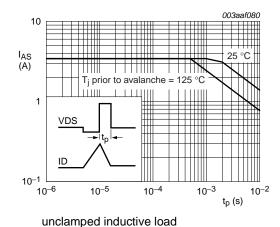


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage



$$I_{\textit{der}} = \frac{I_{\textit{D}}}{I_{\textit{D(25°C)}}} \times 100\,\%$$

Fig 2. Normalized continuous drain current as a function of ambient temperature



unciamped inductive load

Fig 4. Single-shot avalanche rating; avalanche current as a function of avalanche period

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5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance	Surface mounted; FR4 board	-	150	-	K/W
	from junction to ambient	Surface mounted; FR4 board; t ≤ 10 sec	-	-	62.5	K/W

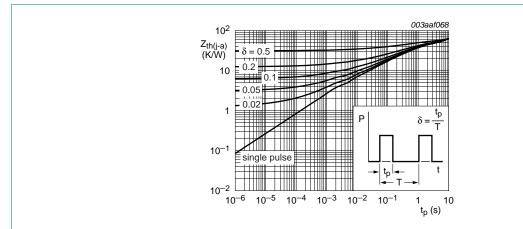


Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration

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6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _{(BR)DSS}	drain-source	$I_D = 10 \mu A; V_{GS} = 0 V; T_j = 25 °C$	30	-	-	V
	breakdown voltage	$I_D = 10 \mu A; V_{GS} = 0 V; T_j = -55 °C$	27	-	-	V
V _{GS(th)}	gate-source threshold	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}$	-	-	3.2	V
	voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ °C}$	0.4	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	1	2	2.8	V
I _{DSS}	drain leakage current	$V_{DS} = 24 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nΑ
		$V_{DS} = 24 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	0.6	10	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nΑ
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nΑ
R _{DSon}	drain-source on-state	$V_{GS} = 4.5 \text{ V}; I_D = 1 \text{ A}; T_j = 25 ^{\circ}\text{C}$	-	120	200	mΩ
	resistance	V _{GS} = 10 V; I _D = 2.2 A; T _j = 150 °C	-	-	170	mΩ
		V _{GS} = 10 V; I _D = 2.2 A; T _j = 25 °C	-	80	100	mΩ
I _{DSon}	on-state drain current	V _{DS} = 1 V; V _{GS} = 10 V	3.5	-	-	Α
		V _{DS} = 5 V; V _{GS} = 4.5 V	2	-	-	Α
Dynamic o	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 2.3 \text{ A}; V_{DS} = 15 \text{ V}; V_{GS} = 10 \text{ V};$	-	6	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C	-	0.7	-	nC
Q_{GD}	gate-drain charge		-	0.7	-	nC
C _{iss}	input capacitance	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	250	-	pF
C _{oss}	output capacitance	$T_j = 25 ^{\circ}\text{C}$	-	88	-	pF
C_{rss}	reverse transfer capacitance		-	54	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 20 \text{ V}; R_L = 18 \Omega; V_{GS} = 10 \text{ V};$	-	6	-	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	8	-	ns
t _{d(off)}	turn-off delay time		-	21	-	ns
t _f	fall time		-	15	-	ns
9 _{fs}	transfer conductance	$V_{DS} = 20 \text{ V}; I_D = 2.2 \text{ A}; T_j = 25 \text{ °C}$	2	4.5	-	S
L _D	internal drain inductance	measured from drain lead to centre of die, $T_j = 25$ °C	-	2.5	-	nΗ
L _S	internal source inductance	measured from source lead to source bond pad; $T_j = 25$ °C	-	5	-	nΗ
Source-dr	ain diode	•				
V_{SD}	source-drain voltage	I _S = 1.25 A; V _{GS} = 0 V; T _i = 25 °C	-	0.82	1.2	V
t _{rr}	reverse recovery time	$I_S = 1.25 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	69	-	ns
Q _r	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; T_j = 25 \text{ °C}$		55	_	nC

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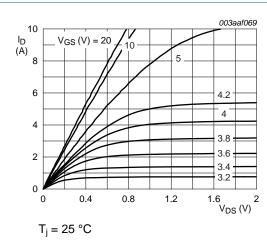


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values

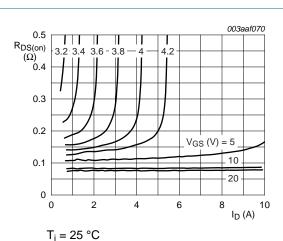


Fig 7. Drain-source on-state resistance as a function of drain current; typical values

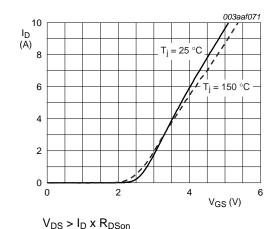


Fig 8. Transfer characteristics: drain current as a function of gate-source voltage; typical values

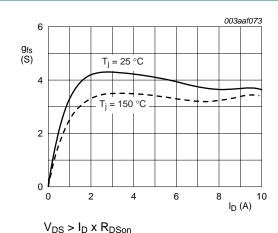


Fig 9. Forward transconductance as a function of drain current; typical values

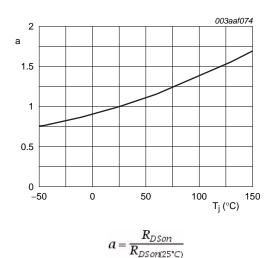
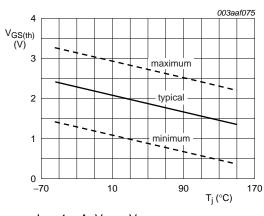


Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature



 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 11. Gate-source threshold voltage as a function of junction temperature

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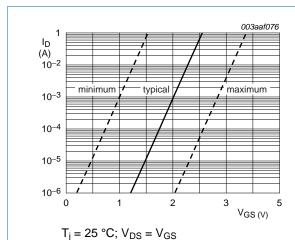
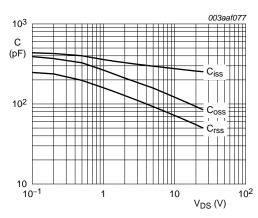
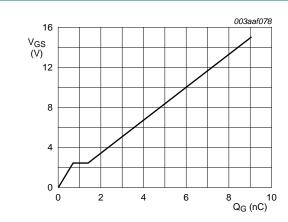


Fig 12. Sub-threshold drain current as a function of gate-source voltage



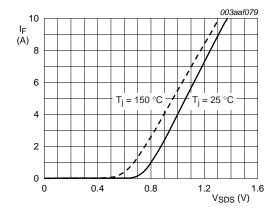
 $V_{GS} = 0 V$; f = 1 MHz

Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



 $I_D = 2.3 \text{ A}; T_j = 25 \text{ °C}; V_{DD} = 15 \text{ V}$

Fig 14. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0 V$

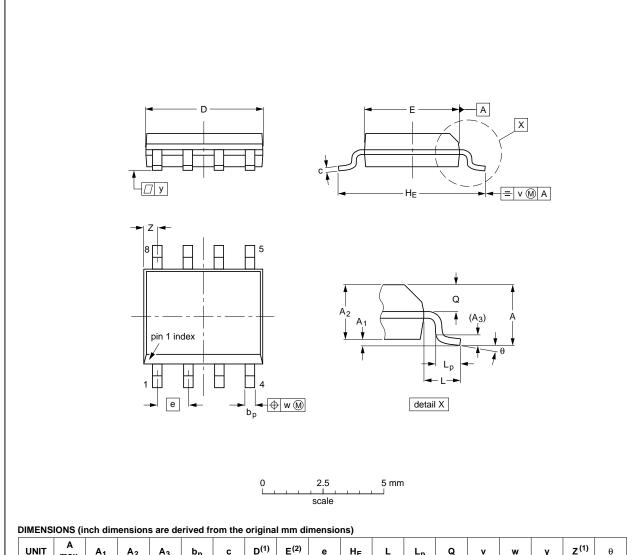
Fig 15. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

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7. Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	٦	Lp	ø	٧	¥	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.20 0.19	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016		0.01	0.01	0.004	0.028 0.012	0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

EC JEDE	С	JEITA		PROJECTION	ISSUE DATE
		V=1174		PROJECTION	
E03 MS-01	12				99-12-27 03-02-18
	E03 MS-01	E03 MS-012	E03 MS-012	E03 MS-012	E03 MS-012

Fig 16. Package outline SOT96-1 (SO8)

PHN210T

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes					
PHN210T v.2	20101215	Product data sheet	-	PHN210T v.1					
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 								
 Legal texts have been adapted to the new company name where appropriate. 									
PHN210T v.1	19990301	Product specification	-	-					

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9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
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